

**Search Notes**

Application/Control No.

10/712,136

Examiner

Khanh V. Nguyen

Applicant(s)/Patent under  
Reexamination

SNIDER ET AL.

Art Unit

2817

**SEARCHED**

Class	Subclass	Date	Examiner
330	85, 138, 140, 279, 290	1/28/2005	NKV
ABOVE	UPDATED	7/8/2005	NKV

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
CLASSES	ABOVE	7/8/2005	NKV

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB) (see history printout)	7/8/2005	NKV